

AUG 09 2002
PATENT & TRADEMARK OFFICE

		Atty. Docket No. 1074D2	Serial No. 10/075,021
LIST OF CITATIONS BY APPLICANT (Use several sheets if necessary)		Applicant James J. Finley et al.	
		Filing Date February 12, 2002	Group 1775

U.S. PATENT DOCUMENTS

Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
ATP	AA	3,655,545	4/72	Gillery et al.	204	192	
	AB	3,962,488	6/76	Gillery	204	192	
	AC	4,194,022	3/80	Gillery	427	109	
	AD	4,716,086	12/87	Gillery et al.	428	630	
	AE	4,717,632	1/88	Keem et al.	428	698	
	AF	4,786,563	11/88	Gillery et al.	428	630	
	AG	4,806,220	2/89	Finley	204	192.27	
	AH	4,898,789	2/90	Finley	428	623	
	AI	4,898,790	2/90	Finley	428	623	
	AJ	5,028,759	7/91	Finley	219	203	
ATP	AK	5,059,295	10/91	Finley	204	192.27	

RECEIVED
AUG 13 2002
TECHNOLOGY CENTER

COPY OF PAPER
ORIGINALLY FILED

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation Yes	No
ATP	AL	2,178,064	2/87	Great Britain				
ATP	AM	0 354 391	2/90	EPO				

OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

ATP	AR	Inoue et al., <u>Materials Letters</u> 16 (1993) pp. 181-184, "Nitrogen-induced amorphization in $Al_{80}Ti_{20}$ films prepared by reactive sputtering"
ATP	AS	Geraghty, K. G. et al., "Kinetics of the Reactive Sputter Deposition of Titanium Oxides", <u>JOURNAL OF THE ELECTROCHEMICAL SOCIETY</u> , Aug. 1976, Vol. 123, Nr. 8, Pages 1201-1207
ATP	AT	Yoshitake, M. et al., "The Use of Ion Beam Current as a Process Control in the Reactive Sputtering of Zirconium Oxide", <u>THIN SOLID FILMS</u> , 15 July 1993, Vol. 230, Nr. 1, Pages 48-54

Examiner <i>G. J.</i>	Date Considered 1/26/03
--------------------------	----------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

PATENT & TRADEMARK OFFICE AUG 09 2002		Atty. Docket No. 1074D2	Serial No. 10/075,021
LIST OF CITATIONS BY APPLICANT (Use several sheets if necessary)		Applicant James J. Finley et al.	
		Filing Date February 12, 2002	Group 1775

U.S. PATENT DOCUMENTS

Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
ATP	AA	5,062,937	11/91	Komuro	204	192.15	
	AB	5,073,451	12/91	Iida et al.	428	336	
	AC	5,087,340	2/92	Onagi et al.	204	192.2	
	AD	5,110,637	5/92	Ando et al.	204	192.16	
	AE	5,128,214	7/92	Takayanagi et al.	428	681	
	AF	5,209,835	5/93	Makino et al.	204	192.16	
	AG	5,270,517	12/93	Finley	219	203	
	AH	5,292,417	3/94	Kugler	204	192.13	
	AI	5,302,449	4/94	Eby et al.	428	336	
	AJ	5,302,461	4/94	Anthony	428	472	
ATP	AK	5,318,685	6/94	O'Shaughnessy	204	192.27	

FOREIGN PATENT DOCUMENTS

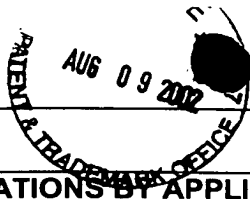
		Document No.	Date	Country	Class	Subclass	Translation Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							
	AQ							

OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

ATP	AR	U.S. Patent Application Serial No. 08/151,229 filed November 12, 1993.
	AS	
	AT	

Examiner g = P.	Date Considered 1/29/03
--------------------	----------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Atty. Docket No. 1074D2		Serial No. 10/075,021
LIST OF CITATIONS BY APPLICANT (Use several sheets if necessary)		Applicant James J. Finley et al.
Filing Date February 12, 2002		Group 1775

U.S. PATENT DOCUMENTS

Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
ATP	AA	5,332,618	7/94	Austin	428	216	
	AB	4,522,844	6/85	Khanna et al.	204	192.11	
	AC	4,696,731	9/87	Tenhover	204	192.15	
	AD	5,078,846	1/92	Miller et al.	204	192.15	
	AE	5,108,846	4/92	Steininger	204	192.15	
	AF	5,110,662	5/92	Depauw et al.	204	192.26	
ATP	AG	6,346,174	2/02	Finley et al.	204	192.15	
	AH						
	AI						
	AJ						
	AK						

RECEIVED
AUG 13 2002
TECHNOLOGY CENTER 1100

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation Yes No
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						

COPY OF PAPERS
ORIGINALLY FILED

OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	
	AS	
	AT	

Examiner <i>g-17</i>	Date Considered 1/29/03
-------------------------	----------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.